

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ANNIC, ETIENNE	
		Examiner. Khawar Iqbal	Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0110097	08-2002	Sugirtharaj et al.	370/329
*	B	US-2004/0166843	08-2004	Hahn, Wolfgang	455/426.2
*	C	US-2004/0151155	08-2004	Jouppi, Jarkko	370/349
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**NON-PATENT DOCUMENTS**

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